

TEST REPORT

Product Name : Bluetooth Earphone
Brand Mark : N/A
Model No. : TWS-587, T7
FCC ID : 2AB75-TWS-587
Report Number : BLA-EMC-202005-A2901
Date of Sample Receipt : 2020/5/11
Date of Test : 2020/5/14 to 2020/5/19
Date of Issue : 2020/5/19
Test Standard : 47 CFR Part 15, Subpart C 15.247
Test Result : Pass

Prepared for:

Wintop Electronics Co., Limited

**Flat 2, 8/F Workingport Com'L Bldg, 3 Hau Fook ST, Tsim Sha Tsui, Kln
Hong Kong**

Prepared by:

BlueAsia of Technical Services(Shenzhen) Co.,Ltd.

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Date: 2020/5/19



REPORT REVISE RECORD

Version No.	Date	Description
00	2020/5/19	Original

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1 TEST SUMMARY

Test item	Test Requirement	Test Method	Class/Severity	Result
Radiated Emissions which fall in the restricted bands	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 6.10.5	47 CFR Part 15, Subpart C 15.209 & 15.247(d)	Pass
Antenna Requirement	47 CFR Part 15, Subpart C 15.247	N/A	47 CFR Part 15, Subpart C 15.203 & 15.247(c)	Pass
Conducted Band Edges Measurement	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.8 & Section 11.13.3.2	47 CFR Part 15, Subpart C 15.247(d)	Pass
Conducted Spurious Emissions	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.6 & Section 11.11	47 CFR Part 15, Subpart C 15.247(d)	Pass
Dwell Time	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.4	47 CFR Part 15, Subpart C 15.247a(1)(iii)	Pass
Hopping Channel Number	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.3	47 CFR Part 15, Subpart C 15.247a(1)(iii)	Pass
Carrier Frequencies Separation	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.2	47 CFR Part 15, Subpart C 15.247a(1)	Pass
20dB Bandwidth	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.7	47 CFR Part 15, Subpart C 15.247(a)(1)	Pass
Conducted Peak Output Power	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.5	47 CFR Part 15, Subpart C 15.247(b)(3)	Pass
Conducted Emissions at AC Power Line (150kHz-30MHz)	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 6.2	47 CFR Part 15, Subpart C 15.207	Pass
Radiated Spurious Emissions	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 6.4,6.5,6.6	47 CFR Part 15, Subpart C 15.209 & 15.247(d)	Pass

2 GENERAL INFORMATION

Applicant	Wintop Electronics Co., Limited
Address	Flat 2,8/F Workingport Com'L Bldg,3 Hau Fook ST,Tsim Sha Tsui,Kln Hong Kong
Manufacturer	ShenZhen Wintop Electronics Co.,Ltd
Address	Room 402 Building 1 No.34 XinHe Road, No 46 XinHe Road, Floor 4 No.50 XinHe Road ShangMuGu Community,PingHu Street,LongGang District,ShenZhen City,GuangDong Province,China
Factory	ShenZhen Wintop Electronics Co.,Ltd
Address	Room 402 Building 1 No.34 XinHe Road, No 46 XinHe Road, Floor 4 No.50 XinHe Road ShangMuGu Community,PingHu Street,LongGang District,ShenZhen City,GuangDong Province,China
Product Name	Bluetooth Earphone
Test Model No.	TWS-587

3 GENERAL DESCRIPTION OF E.U.T.

Hardware Version	TWS587_1V1
Software Version	V1
Operation Frequency:	2402MHz-2480MHz
Modulation Type:	GFSK, pi/4DQPSK, 8DPSK
Channel Spacing:	1MHz
Number of Channels:	79
Antenna Type:	Chip Antenna
Antenna Gain:	-0.5dBi

4 TEST ENVIRONMENT

Environment	Temperature	Voltage
Normal	25°C	DC3.7V

5 TEST MODE

TEST MODE	TEST MODE DESCRIPTION
TX	Keep the EUT in continuously transmitting mode with modulation. (hopping or non hopping mode all have been tested ,only worse case non hopping mode is reported for RE)
Remark: Full battery is used during all test except ac conducted emission, DH1, DH3, DH5 all have been tested, during the test, GFSK, Pi/4QPSK, 8-DPSK modulation were all pre-scanned only worse case is reported.	

6 MEASUREMENT UNCERTAINTY

Parameter	Expanded Uncertainty (Confidence of 95%)
Radiated Emission	±4.34dB
Radiated Emission	±4.24dB
Radiated Emission	±4.68dB
AC Power Line Conducted Emission	±3.45dB

Parameter	Expanded Uncertainty (Confidence of 95%)
Occupied Channel Bandwidth	±5 %
RF output power, conducted	±1.5 dB
Power Spectral Density, conducted	±3.0 dB
Unwanted Emissions, conducted	±3.0 dB
Temperature	±3 °C
Supply voltages	±3 %
Time	±5 %
Radiated Emission (30MHz ~ 1000MHz)	±4.35 dB
Radiated Emission (1GHz ~ 18GHz)	±4.44 dB

7 DESCRIPTION OF SUPPORT UNIT

Device Type	Manufacturer	Model Name	Serial No.	Remark
AC Adapter (UGREEN)	UGREEN	CD112	N/A	N/A
PC	HASEE	K610D	N/A	N/A

8 LABORATORY LOCATION

All tests were performed at:
BlueAsia of Technical Services(Shenzhen) Co., Ltd.
IOT Test Centre of BlueAsia
No. 448 Bulong Road, Bantian Street, Longgang District, Shenzhen, China
Telephone: TEL: +86-755-28682673 FAX: +86-755-28682673
No tests were sub-contracted.

9 TEST INSTRUMENTS LIST

Test Equipment Of Radiated Emissions which fall in the restricted bands					
Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Chamber	SKET	966	N/A	5/8/2018	5/7/2021
Spectrum	R&S	FSP40	100817	7/4/2019	7/3/2020
Receiver	R&S	ESR7	101199	4/20/2020	4/19/2021
broadband Antenna	Schwarzbeck	VULB9168	00836 P:00227	7/14/2018	7/13/2020
Horn Antenna	Schwarzbeck	9120D	01892 P:00331	7/14/2018	7/13/2020
Amplifier	SKET	LNPA-0118-45	N/A	7/4/2019	7/3/2020
EMI software	EZ	EZ-EMC	N/A	N/A	N/A
Loop antenna	SCHNARZBECK	FMZB1519B	00102	2/14/2019	2/13/2022
Controller	SKET	N/A	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-02	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-03	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-01	N/A	N/A	N/A

Test Equipment Of Conducted Band Edges Measurement					
Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/4/2019	7/3/2020
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Conducted Spurious Emissions					
Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due

Spectrum	R&S	FSP40	100817	7/4/2019	7/3/2020
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Dwell Time

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/4/2019	7/3/2020
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Hopping Channel Number

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/4/2019	7/3/2020
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Carrier Frequencies Separation

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/4/2019	7/3/2020
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020

Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021
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Test Equipment Of 20dB Bandwidth

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/4/2019	7/3/2020
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Conducted Peak Output Power

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/4/2019	7/3/2020
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Conducted Emissions at AC Power Line (150kHz-30MHz)

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Shield room	SKET	833	N/A	6/10/2018	6/9/2021
Receiver	R&S	ESPI3	101082	4/20/2020	4/19/2021
LISN	R&S	ENV216	3560.6550.15	7/4/2019	7/3/2020
LISN	AT	AT166-2	AKK1806000003	12/17/2019	12/16/2020
EMI software	EZ	EZ-EMC	N/A	N/A	N/A

Test Equipment Of Radiated Spurious Emissions

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Email:marketing@cblueasia.com

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Chamber	SKET	966	N/A	5/8/2018	5/7/2021
Spectrum	R&S	FSP40	100817	7/4/2019	7/3/2020
Receiver	R&S	ESR7	101199	4/20/2020	4/19/2021
broadband Antenna	Schwarzbeck	VULB9168	00836 P:00227	7/14/2018	7/13/2020
Horn Antenna	Schwarzbeck	9120D	01892 P:00331	7/14/2018	7/13/2020
Amplifier	SKET	LNPA-0118-45	N/A	7/4/2019	7/3/2020
EMI software	EZ	EZ-EMC	N/A	N/A	N/A
Loop antenna	SCHNARZBECK	FMZB1519B	00102	2/14/2019	2/13/2022
Controller	SKET	N/A	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-02	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-03	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-01	N/A	N/A	N/A

RADIATED EMISSIONS WHICH FALL IN THE RESTRICTED BANDS

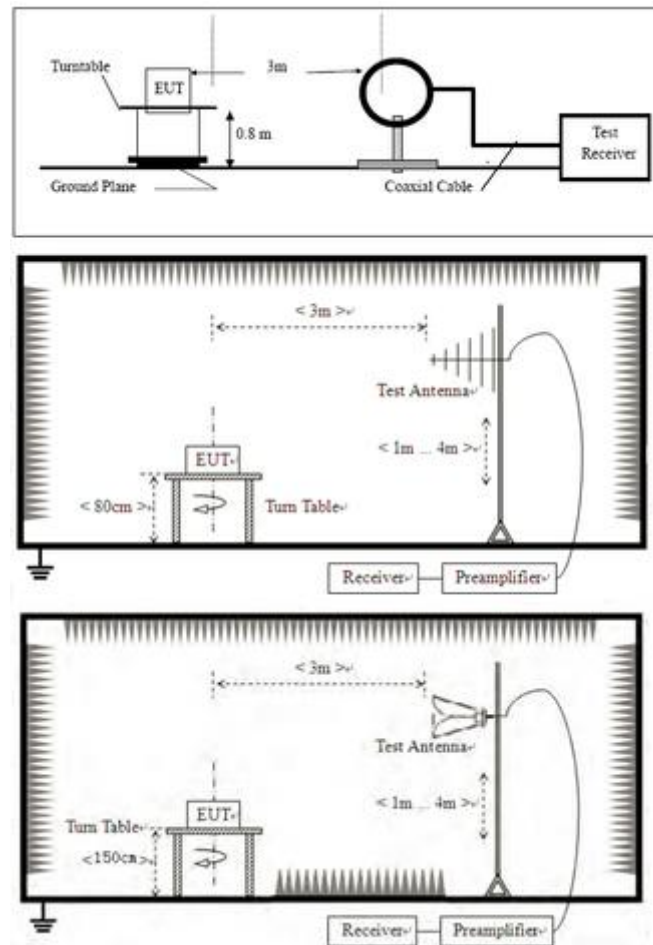
Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 6.10.5
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Jozu
Temperature	25°C
Humidity	60%

LIMITS

Frequency(MHz)	Field strength(microvolts/meter)	Measurement distance(meters)
0.009-0.490	2400/F(kHz)	300
0.490-1.705	24000/F(kHz)	30
1.705-30.0	30	30
30-88	100	3
88-216	150	3
216-960	200	3
Above 960	500	3

Remark: The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9-90kHz, 110-490kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector, the peak field strength of any emission shall not exceed the maximum permitted average limits specified above by more than 20 dB under any condition of modulation.

BLOCK DIAGRAM OF TEST SETUP



PROCEDURE

- For below 1GHz, the EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 or 10 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- For above 1GHz, the EUT was placed on the top of a rotating table 1.5 meters above the ground at a 3 meter fully-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- The EUT was set 3 or 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.
- If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.

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- h. Test the EUT in the lowest channel, the middle channel, the Highest channel.
- i. The radiation measurements are performed in X, Y, Z axis positioning for Transmitting mode, and found the X axis positioning which it is the worst case.
- j. Repeat above procedures until all frequencies measured was complete.

Remark 1: $\text{Level} = \text{Read Level} + \text{Cable Loss} + \text{Antenna Factor} - \text{Preamp Factor}$

Remark 2: For frequencies above 1GHz, the field strength limits are based on average limits. However, the peak field strength of any emission shall not exceed the maximum permitted average limits specified above by more than 20 dB under any condition of modulation. For the emissions whose peak level is lower than the average limit, only the peak measurement is shown in the report.

TEST DATA

[Test Mode: 8DPSK] Remark: During the test, pre-scan the GFSK, Pi/4QPSK, 8-DPSK modulation, and found the 8-DPSK modulation which it is worse case.						
Test channel:lowest						
Peak value:						
Frequency (MHz)	Read Level (dBuV)	Correct factor	Level (dBuV/m)	Limit Line (dBuV/m)	Over Limit (dB)	Polarization
2310	44.9	-4.2	40.7	74	-33.3	Horizontal
2390	47.77	-3.88	43.89	74	-30.11	Horizontal
2310	47	-4.49	42.51	74	-31.49	Vertical
2390	51.49	-4.21	47.28	74	-26.72	Vertical
Average value:						
Frequency (MHz)	Read Level (dBuV)	Correct factor(dB/m)	Level (dBuV/m)	Limit Line (dBuV/m)	Over Limit (dB)	Polarization
2310	35.08	-4.2	30.88	54	-23.12	Horizontal
2390	33.74	-3.88	29.86	54	-24.14	Horizontal
2310	32.92	-4.49	28.43	54	-25.57	Vertical
2390	33.58	-4.21	29.37	54	-24.63	Vertical
Test channel:Highest						
Peak value:						
Frequency (MHz)	Read Level (dBuV)	Correct factor	Level (dBuV/m)	Limit Line (dBuV/m)	Over Limit (dB)	Polarization
2483.5	51.81	-3.38	48.43	74	-25.57	Horizontal
2500	51.46	-3.3	48.16	74	-25.84	Horizontal
2483.5	48.34	-3.77	44.57	74	-29.43	Vertical
2500	53.4	-3.7	49.7	74	-24.3	Vertical
Average value:						
Frequency (MHz)	Read Level (dBuV)	Correct factor(dB/m)	Level (dBuV/m)	Limit Line (dBuV/m)	Over Limit (dB)	Polarization
2483.5	41.61	-3.38	38.23	54	-15.77	Horizontal
2500	40.09	-3.3	36.79	54	-17.21	Horizontal
2483.5	38.57	-3.77	34.8	54	-19.2	Vertical
2500	38.89	-3.7	35.19	54	-18.81	Vertical
Test Result: Pass						

ANTENNA REQUIREMENT

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	N/A

CONCLUSION

Standard Requirement:

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit permanently attached antenna or of an so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

EUT Antenna:

The antenna is integrated on the main PCB and no consideration of replacement. The best case gain of the antenna is -0.5dBi.



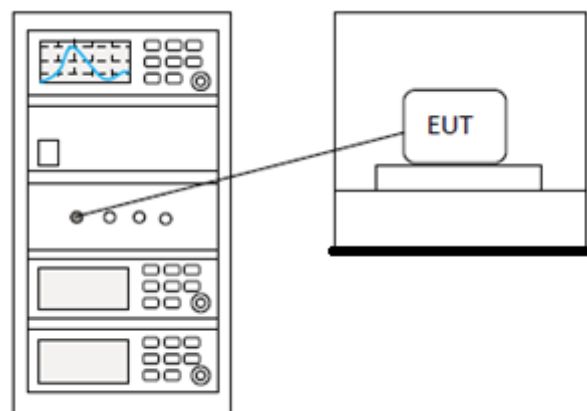
CONDUCTED BAND EDGES MEASUREMENT

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.8 & Section 11.13.3.2
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Jozu
Temperature	25℃
Humidity	60%

LIMITS

Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).
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BLOCK DIAGRAM OF TEST SETUP



TEST DATA

Pass: Please Refer To Appendix: Appendix2 For Details

BlueAsia

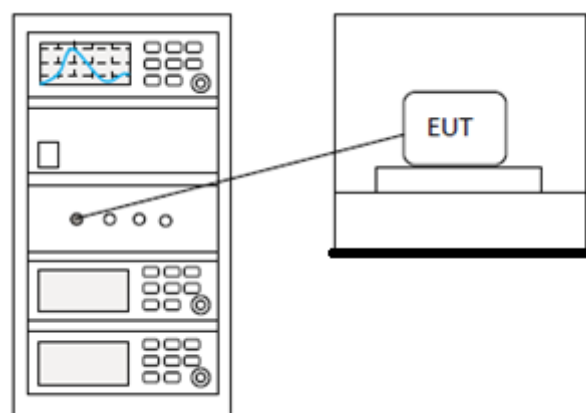
CONDUCTED SPURIOUS EMISSIONS

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.6 & Section 11.11
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Jozu
Temperature	25℃
Humidity	60%

LIMITS

Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).
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BLOCK DIAGRAM OF TEST SETUP



TEST DATA**Pass: Please Refer To Appendix: Appendix2 For Details**

BlueAsia

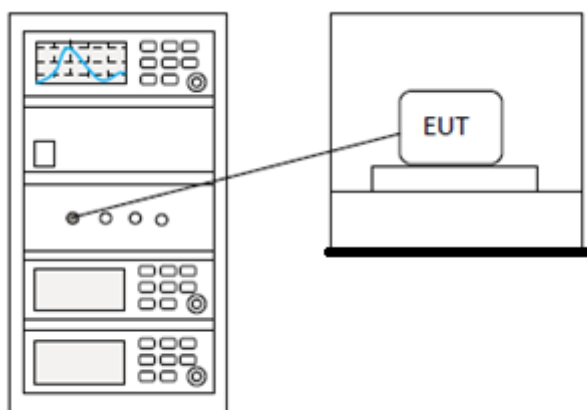
DWELL TIME

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.4
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Jozu
Temperature	25℃
Humidity	60%

LIMITS

Frequency(MHz)	Limit
902-928	0.4S within a 20S period(20dB bandwidth<250kHz)
	0.4S within a 10S period(20dB bandwidth≥250kHz)
2400-2483.5	0.4S within a period of 0.4S multiplied by the number of hopping channels
5725-5850	0.4S within a 30S period

BLOCK DIAGRAM OF TEST SETUP



TEST DATA

Pass: Please Refer To Appendix: Appendix2 For Details

BlueAsia

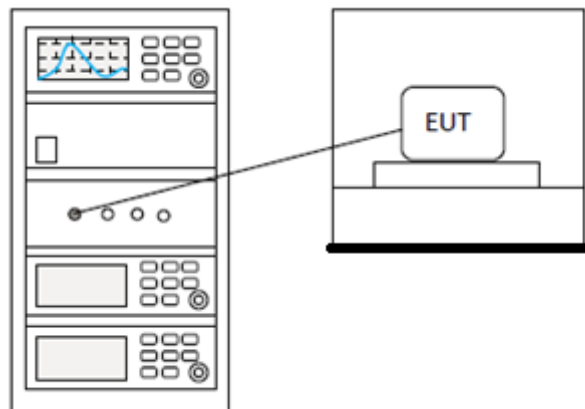
HOPPING CHANNEL NUMBER

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.3
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Jozu
Temperature	25℃
Humidity	60%

LIMITS

Frequency range(MHz)	Number of hopping channels (minimum)
902-928	50 for 20dB bandwidth <250kHz
	25 for 20dB bandwidth ≥250kHz
2400-2483.5	15
5725-5850	75

BLOCK DIAGRAM OF TEST SETUP



TEST DATA

Pass: Please Refer To Appendix: Appendix2 For Details

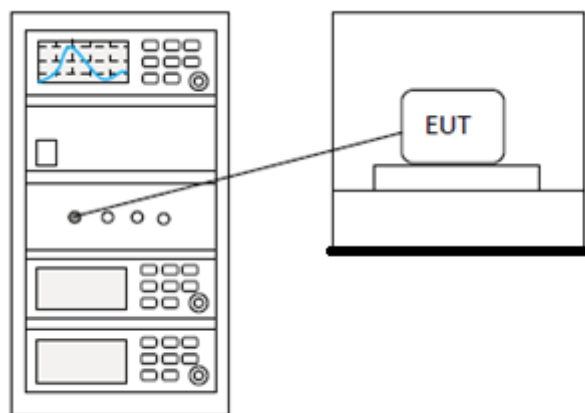
CARRIER FREQUENCIES SEPARATION

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.2
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Jozu
Temperature	25°C
Humidity	60%

LIMITS

Limit:	2/3 of the 20dB bandwidth base on the transmission power is less than 0.125W
---------------	--

BLOCK DIAGRAM OF TEST SETUP



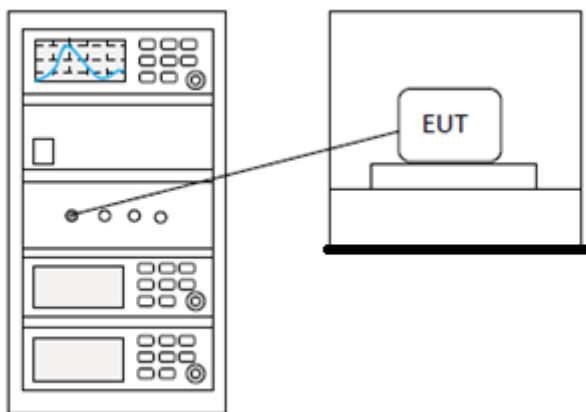
TEST DATA

Pass: Please Refer To Appendix: Appendix2 For Details

20DB BANDWIDTH

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.7
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Jozu
Temperature	25 °C
Humidity	60%

BLOCK DIAGRAM OF TEST SETUP



TEST DATA

Pass: Please Refer To Appendix: Appendix2 For Details

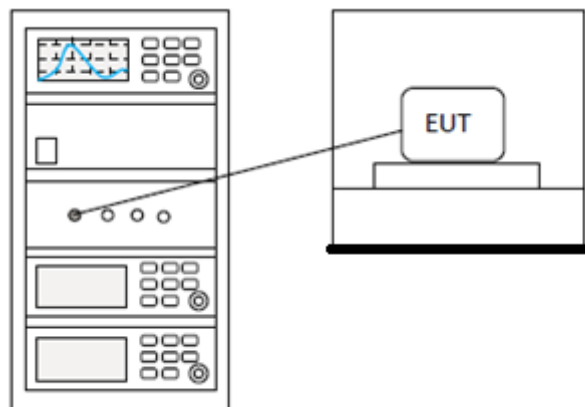
CONDUCTED PEAK OUTPUT POWER

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.5
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Jozu
Temperature	25°C
Humidity	60%

LIMITS

Frequency range(MHz)	Output power of the intentional radiator(watt)
902-928	1 for ≥ 50 hopping channels
	0.25 for $25 \leq \text{hopping channels} < 50$
	1 for digital modulation
2400-2483.5	1 for ≥ 75 non-overlapping hopping channels
	0.125 for all other frequency hopping systems
	1 for digital modulation
5725-5850	1 for frequency hopping systems and digital modulation

BLOCK DIAGRAM OF TEST SETUP



TEST DATA

Pass: Please Refer To Appendix: Appendix2 For Details

BlueAsia

CONDUCTED EMISSIONS AT AC POWER LINE (150KHZ-30MHZ)

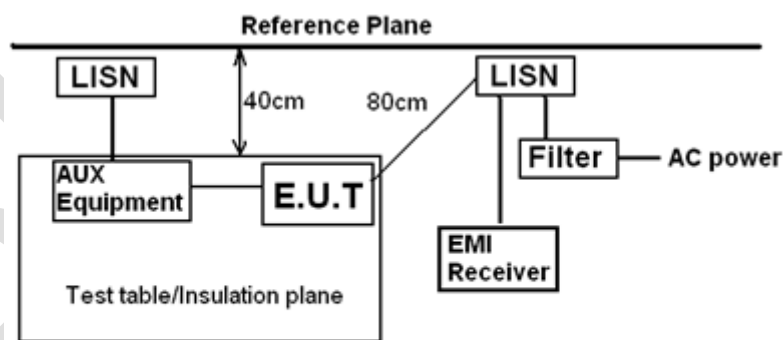
Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 6.2
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Jozu
Temperature	25℃
Humidity	60%

LIMITS

Frequency of emission(MHz)	Conducted limit(dBμV)	
	Quasi-peak	Average
0.15-0.5	66 to 56*	56 to 46*
0.5-5	56	46
5-30	60	50

*Decreases with the logarithm of the frequency.

BLOCK DIAGRAM OF TEST SETUP



Remark
E.U.T: Equipment Under Test
LISN: Line Impedance Stabilization Network
Test table height=0.8m

PROCEDURE

- 1) The mains terminal disturbance voltage test was conducted in a shielded room.
- 2) The EUT was connected to AC power source through a LISN 1 (Line Impedance Stabilization Network) which provides a 50ohm/50?H + 5ohm linear impedance. The power cables of all other units of the EUT were connected to a second LISN 2, which was bonded to the ground reference plane in the same way as the LISN 1 for the unit being measured. A multiple socket outlet strip was used to connect multiple power

cables to a single LISN provided the rating of the LISN was not exceeded.

3) The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane,

4) The test was performed with a vertical ground reference plane. The rear of the EUT shall be 0.4 m from the vertical ground reference plane. The vertical ground reference plane was bonded to the horizontal ground reference plane. The LISN 1 was placed 0.8 m from the boundary of the unit under test and bonded to a ground reference plane for LISNs mounted on top of the ground reference plane. This distance was between the closest points of the LISN 1 and the EUT. All other units of the EUT and associated equipment was at least 0.8 m from the LISN 2.

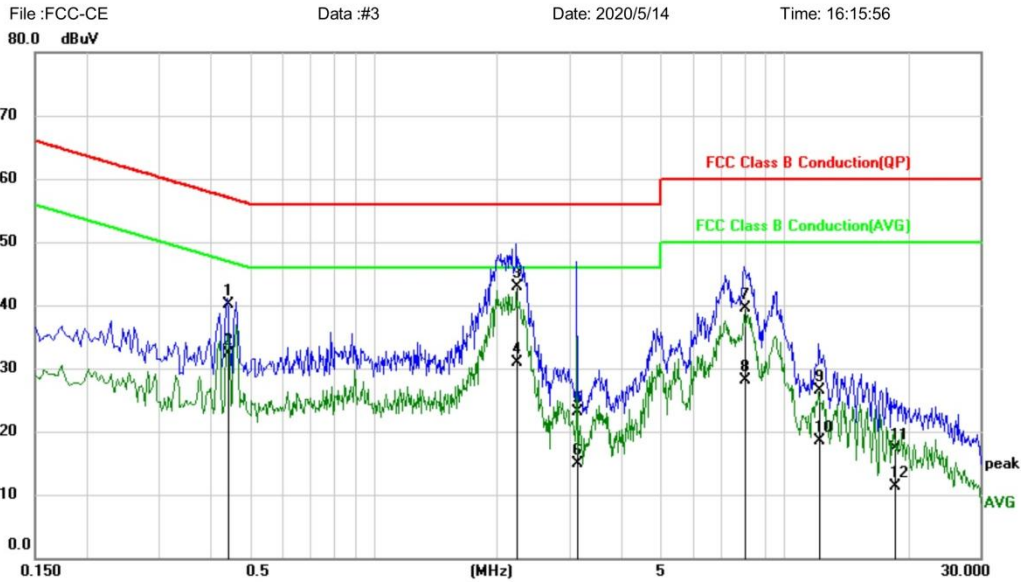
5) In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to ANSI C63.10 on conducted measurement.

Remark: $LISN = Read\ Level + Cable\ Loss + LISN\ Factor$

TEST DATA

[TestMode: TX]; [Line: Line]

Conducted Emission Measurement



Site: Phase: **L1** Temperature: 26
Limit: FCC Class B Conduction(QP) Power: AC120V/60Hz Humidity: 60 %
EUT: Bluetooth Earphone
M/N: TWS-587
Mode: BT mode
Note:

No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector	Comment
1		0.4420	30.38	9.69	40.07	57.02	-16.95	QP	
2		0.4420	22.66	9.69	32.35	47.02	-14.67	AVG	
3	*	2.2300	33.15	9.82	42.97	56.00	-13.03	QP	
4		2.2300	21.14	9.82	30.96	46.00	-15.04	AVG	
5		3.1380	13.20	9.87	23.07	56.00	-32.93	QP	
6		3.1380	5.13	9.87	15.00	46.00	-31.00	AVG	
7		8.0100	29.65	9.87	39.52	60.00	-20.48	QP	
8		8.0100	18.28	9.87	28.15	50.00	-21.85	AVG	
9		12.1540	16.57	9.96	26.53	60.00	-33.47	QP	
10		12.1540	8.47	9.96	18.43	50.00	-31.57	AVG	
11		18.5860	7.20	10.02	17.22	60.00	-42.78	QP	
12		18.5860	1.22	10.02	11.24	50.00	-38.76	AVG	

*:Maximum data x:Over limit !:over margin

⟨Reference Only

Test Result: Pass

[TestMode: TX]; [Line: Nutral]

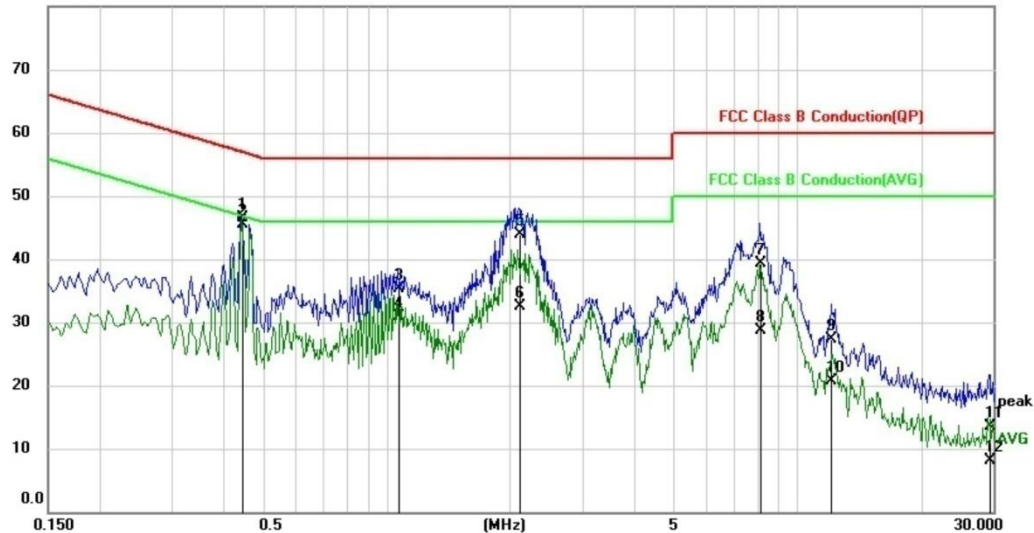
Conducted Emission Measurement

File: FCC-CE
80.0 dBuV

Data: #4

Date: 2020/5/14

Time: 16:18:06



Site

Phase: **N**

Temperature: 26

Limit: FCC Class B Conduction(QP)

Power: AC120V/60Hz

Humidity: 60 %

EUT: Bluetooth Earphone

M/N: TWS-587

Mode: BT mode

Note:

No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector	Comment
1		0.4460	36.76	9.70	46.46	56.95	-10.49	QP	
2	*	0.4460	35.86	9.70	45.56	46.95	-1.39	AVG	
3		1.0660	25.43	9.80	35.23	56.00	-20.77	QP	
4		1.0660	21.14	9.80	30.94	46.00	-15.06	AVG	
5		2.1060	34.10	9.86	43.96	56.00	-12.04	QP	
6		2.1060	22.71	9.86	32.57	46.00	-13.43	AVG	
7		8.1420	29.44	9.88	39.32	60.00	-20.68	QP	
8		8.1420	18.81	9.88	28.69	50.00	-21.31	AVG	
9		12.1180	17.37	10.00	27.37	60.00	-32.63	QP	
10		12.1180	10.71	10.00	20.71	50.00	-29.29	AVG	
11		29.3900	3.35	10.11	13.46	60.00	-46.54	QP	
12		29.3900	-1.99	10.11	8.12	50.00	-41.88	AVG	

*:Maximum data x:Over limit !:over margin

(Reference Only)

Test Result: Pass

RADIATED SPURIOUS EMISSIONS

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 6.4,6.5,6.6
Test Mode (Pre-Scan)	TX mode (SE) above 1G;TX mode (SE) below 1G
Test Mode (Final Test)	TX mode (SE) above 1G;TX mode (SE) below 1G
Tester	Jozu
Temperature	25℃
Humidity	60%

LIMITS

Frequency(MHz)	Field strength(microvolts/meter)	Measurement distance(meters)
0.009-0.490	2400/F(kHz)	300
0.490-1.705	24000/F(kHz)	30
1.705-30.0	30	30
30-88	100	3
88-216	150	3
216-960	200	3
Above 960	500	3

Remark: The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9-90kHz, 110-490kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector, the peak field strength of any emission shall not exceed the maximum permitted average limits specified above by more than 20 dB under any condition of modulation.